


<b>Search Notes</b>  	<b>Application/Control No.</b>  10728387	<b>Applicant(s)/Patent Under Reexamination</b>  DEPTA ET AL.
	<b>Examiner</b>  Cehic, Kenan	<b>Art Unit</b>  2609

SEARCHED			
Class	Subclass	Date	Examiner
370	370/221-224,242-245,258,248-252,403-406	5/17/2007	KC

SEARCH NOTES		
Search Notes	Date	Examiner
PLUS Search	5/15/2007	KC
Consulted with SPE Dang Ton	5/17/2007	KC
Consulted with SPE Kwang Yao	11/6/2007	KC
Consulted with SPE Kwang Yao	3/27/2008	KC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See Interference search printout		